

AP1010W

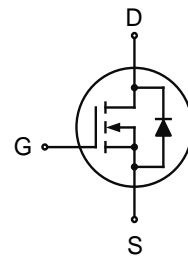
N-Channel Enhancement Mosfet

Features

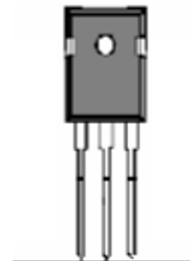
- 60V,100A
 $R_{DS(ON)} < 8m\Omega @ V_{GS}=10V$ TYP:7 m Ω
- Low gate charge
- Fast switching
- 100% avalanche tested
- RoHS product

Applications

- High efficiency switch mode power supplies
- UPS Power



Schematic Diagram



TO-247

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity (PCS)
1010W	AP1010W	TO-247	-	-	600

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ($T_c=25^\circ\text{C}$)	I_D	100	A
Continuous Drain Current ($T_c=100^\circ\text{C}$)	I_D	80	A
Avalanche Current	I_{AR}	80	A
Pulsed Drain Current	I_{DM}	440	A
Drain Power Dissipation	P_D	300	W
Single Pulsed Avalanche Energy	E_{AS}	2970	mJ
Repetitive Avalanche Energy	E_{AR}	20	mJ
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~ +150	$^\circ\text{C}$

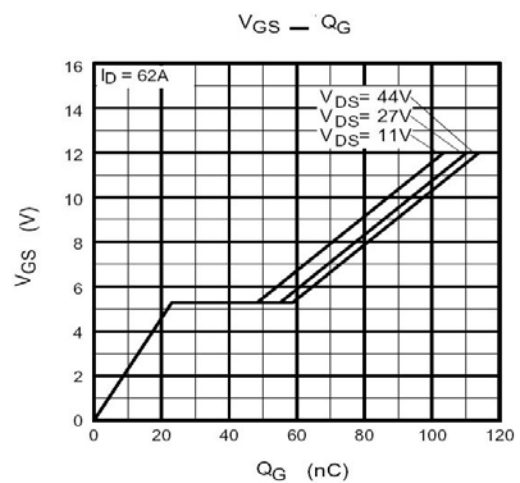
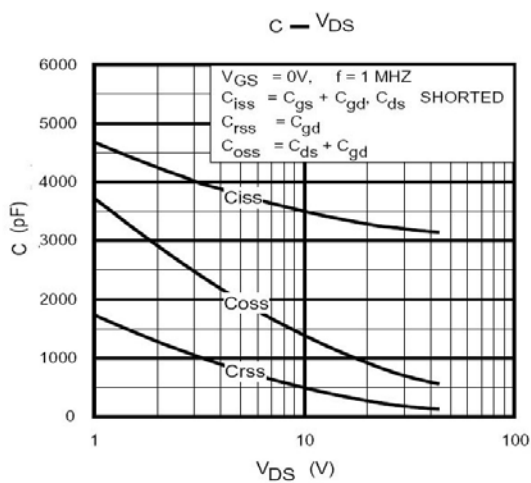
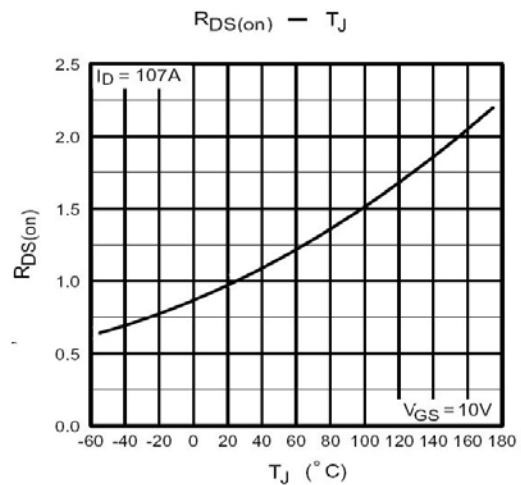
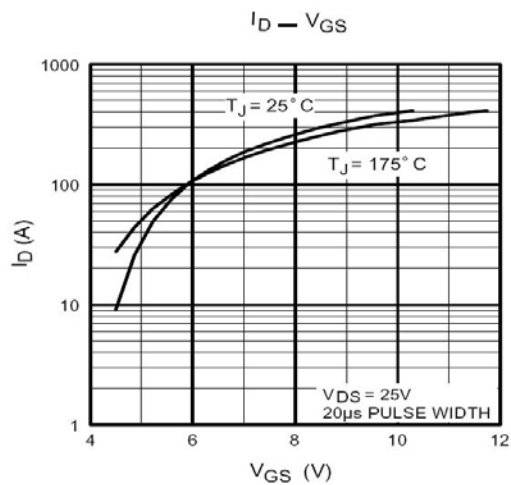
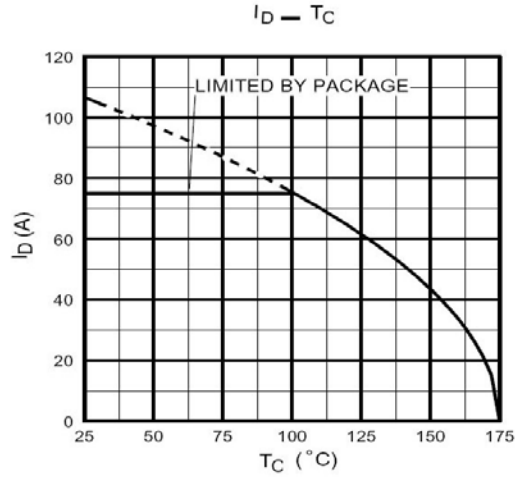
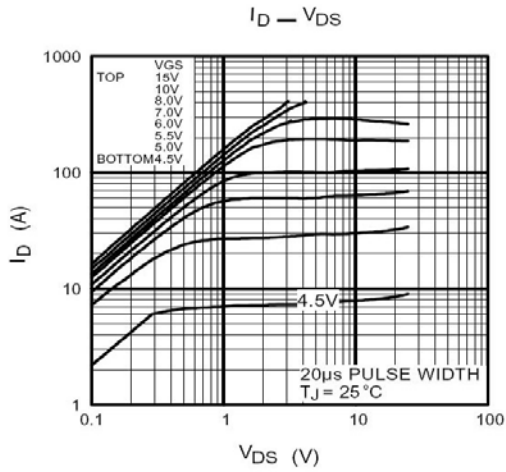
MOSFET ELECTRICAL CHARACTERISTICS($T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Type	Max	Unit
Static Characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	60	-	-	V
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 60V, V_{GS} = 0V$	-	-	1	μA
Gate-body leakage current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	± 100	nA
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.0	-	4.0	V
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 80A$	-	7	8	m Ω
Forward transconductance	g_{fs}	$V_{DS} = 10V, I_D = 80A$	-	43	-	S
Dynamic characteristics						
Input Capacitance	C_{iss}	$V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz$	-	2750	-	pF
Output Capacitance	C_{oss}		-	749	-	
Reverse Transfer Capacitance	C_{rss}		-	197	-	
Switching characteristics						
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 28V, I_D = 60A, R_G = 25\Omega, V_G = 10V$	-	17	-	ns
Turn-on rise time	t_r		-	122	-	
Turn-off delay time	$t_{d(off)}$		-	57	-	
Turn-off fall time	t_f		-	72	-	
Total Gate Charge	Q_g	$V_{DS} = 48V, I_D = 60A, V_{GS} = 10V$	-	78	-	nC
Gate-Source Charge	Q_{gs}		-	13.2	-	
Gate-Drain Charge	Q_{gd}		-	37.8	-	
Source-Drain Diode characteristics						
Diode Forward voltage	V_{SD}	$T_C = 25^\circ\text{C}, V_{GS} = 0V, I_S = 20A$	-	-	1.3	V
Diode Forward current	I_S	$T_C = 25^\circ\text{C}$	-	-	100	A
Body Diode Reverse Recovery Time	t_{rr}	$T_C = 25^\circ\text{C}, I_F = 20A, di/dt = 100A/\mu s$		63		ns
Body Diode Reverse Recovery Charge	Q_{rr}	$T_C = 25^\circ\text{C}, I_F = 20A, di/dt = 100A/\mu s$		63		uc

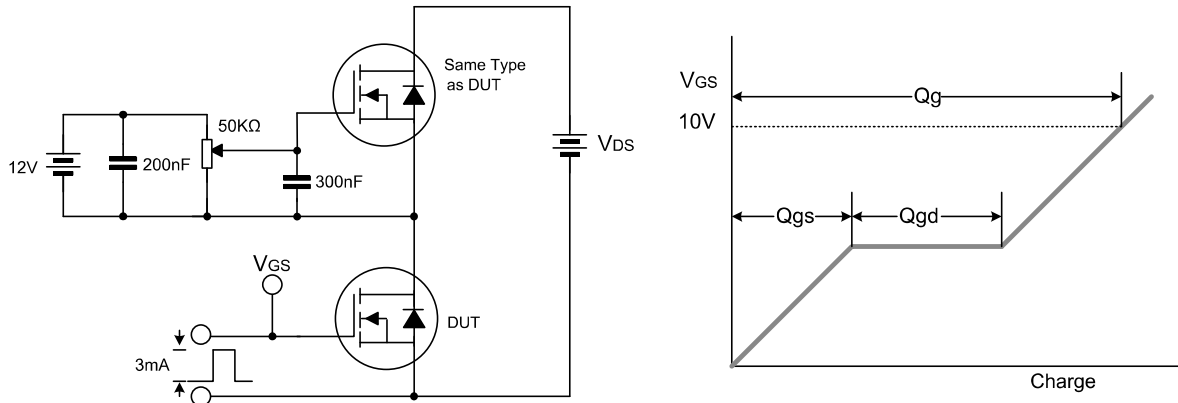
Notes:

- Pulse test ; pulse width $\leq 300 \mu s$, duty cycle $\leq 2\%$
- Guaranteed by design, not subject to production testing

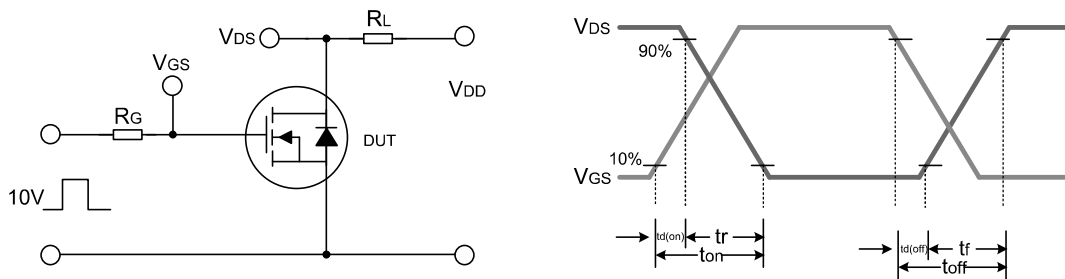
Typical Performance Characteristics



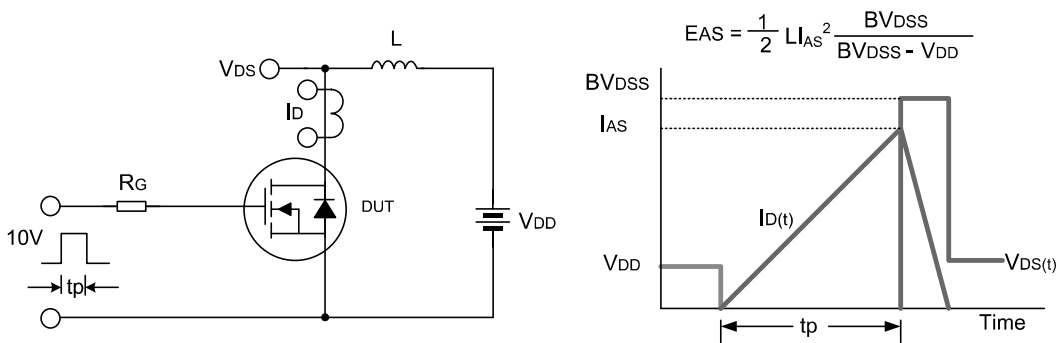
Test Circuit



Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform



EAS Test Circuit & Waveform

TO-247 Package Information

Dimensions in (mm)

